Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/747,689	CHUNG ET AL.	
Examiner	. Art Unit	
Kenneth A. Parker	2871	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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